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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10005705	12/04/2001	257		2815	Jackson

**APPLICANTS: Fukano Hideki;

**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A DIV OF 09/184,218 11/02/1998

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** FOREIGN APPLICATIONS VERIFIED:

JAPAN 9-305148 11/07/1997

JAPAN 9-305149 11/07/1997

JAPAN 9-332587 12/03/1997

PG-PUB	<input type="checkbox"/> DO NOT PUBLISH	<input type="checkbox"/> RESCIND	
Foreign priority claimed 35 USC 119 conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO	
Verified and Acknowledged Examiner's initials		P/3241-21	
TITLE : Semiconductor photo-detector, semiconductor photodetection device, and production methods thereof			
U.S. DEPT. OF COMM./PAT. & TM-PTO-4581 (Rev. 12-94)			

NOTICE OF ALLOWANCE MAILED		Assistant Examiner	CLAIMS ALLOWED	
			Total Claims	Print Claim for O.G
ISSUE FEE		DRAWING		
Amount Due	Date Paid	Sheets Drwg.	Figs.Drwg.	Print Fig.
TERMINAL DISCLAIMER		Primary Examiner		
		PREPARED FOR ISSUE		
		Applicant Examiner		
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